Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,296	FUKUSHIMA ET AL.	
Examiner	Art Unit	
Yahveh Comas	2834	

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	SEARCHED				
Class	Subclass	Date	Examiner		
310	179-183, 201-208, 260	9/16/2005	YC		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		 			
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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